## Application/Control No. Applicant(s)/Patent Under Reexamination 10/809,493 TANAKA ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 3661 Thu Nguyen **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY Sakai et al. 180/204 Α US-6,170,591 B1 01-2001 US-В US-C D US-US-Е F US-G US-US-Н

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